Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/540,200	SCHAFER ET AL.	
Examiner	Art Unit	

Chau N. Nguyen

2831

SEARCHED					
Class	Subclass	Date	Examiner		
174	128.1	3/16/2006	CN		
	110R				
	116				
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
		DATE	EXMR
Text		3/16/2006	CN
Text		7/18/2006	CN
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